## **EAST Search History**

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S98	316	(electrochemical electroplating) and (wafer substrate workpiece semiconductor microelectronics micropiece) and anolyte and catholyte and filter	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 11:19
S99	119	(electroplating electrowinning electrodeposit\$3) and (wafer substrate workpiece semiconductor microelectronics micropiece) and anolyte and catholyte and filter	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 11:30
S10 1	39	S100 not S99	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 11:31
S10 2	8	("3616396"   "4885142"   "5100517"   "5256274"   "5514258"   "6033540"   "6284108"   "6540899").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 11:39
S10 3	334	(electroplating electrowinning electrodeposit\$3 plating deposit\$3) and (wafer substrate workpiece semiconductor microelectronics micropiece) and (anolyte with remov\$3 catholyte with remov\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 11:48
S10 4	237	S103 not (S98 S99 S100)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 11:57
S10 5	130	S103 not (S98 S99 S100) and copper	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 11:59
S10 0	56	(electroplating electrowinning electrodeposit\$3 plating deposit\$3) and (wafer substrate workpiece semiconductor microelectronics micropiece) and (anolyte with filter\$3 catholyte with filter\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:15

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## **EAST Search History**

S10 8	2317	S107 and ("204" "205").clas.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:16
S10 9	542	S108 not (S98 S99 S100) and copper and wafer	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:17
S10 7	6073	(electroplating electrowinning electrodeposit\$3 plating deposit\$3) and (wafer substrate workpiece semiconductor microelectronics micropiece) and anode with (filter\$3 remov\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:17
S10 6	28	S103 not (S98 S99 S100) and copper and wafer	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:17
S11 0	178	(electroplating electrowinning electrodeposit\$3 plating deposit\$3) and (wafer substrate workpiece semiconductor microelectronics micropiece) and anode with (filter\$3 remov\$3) with (contaminant particulate)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/12/28 12:18
S11 1	9	("3763027"   "4062755"   "4269669"   "4372825"   "4391694"   "4431500"   "4696729"   "5217536"   "5514258").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/12/28 12:51

12/28/07 3:16:02 PM C:\Documents and Settings\Izheng\My Documents\EAST\Workspaces\10059907.wsp Page 2

## **EAST Search History**

S11	51	("3962047"   "4137867"   "4170959"	US-PGPUB;	OR	ON	2007/12/28 13:04
2		"4246088"   "4259166"	USPAT;			, .
		"4280882"   "4304641"   "4339297"	USOCR			
		"4341613"   "4466864"				
		"4469566"   "4534832"   "4565607"				
		"4597836"   "4696729"				
		"4828654"   "4861452"   "4879007"				
		"4906346"   "4931149"				
		"5000827"   "5024746"   "5078852"				
		"5096550"   "5135636"				
	•	"5222310"   "5227041"   "5332487"			1	
		"5372699"   "5377708"				
		"5391285"   "5405518"   "5421987"				
		"5441629"   "5443707"   "5447615"				
		"5498325"   "5522975"   "5597460"				
		"5670034"   "5725745"				
		"5750014"   "5776327"   "5788829"				
		"5804052"   "5843296"				
		"5855850").PN.				